Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,964	OIDE ET AL.	
Examiner	Art Unit	_
Scott A. Smith	3721	

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Class	Subclass	Date	Examiner
227	155, 119, 134, 154, 131	12/21/2006	SAS

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
227	155, 119	12/21/2006	SAS
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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	SEARCHED		
Class	Subclass	Date	Examiner
227	155, 119, 134, 154, 131	8/29/2006	SAS
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